



Test Report: PSD-30B-12

30W Single Output Switching Power Supply

■ DESIGN VERIFY TEST

Output Function Test

Input Function Test

Protection Function Test

Component Stress Test

■ SAFETY & E.M.C. TEST

Safety Test

E.M.C. Test

■ RELIABILITY TEST

ENVIRONMENT TEST

DESIGN VERIFY TEST
OUTPUT FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	RIPPLE & NOISE	V1 : 120 mVp-p (Max)	I/P : 24VDC O/P : FULL LOAD Ta : 25°C	V1 : 30 mVp-p (Max)	P
2	OUTPUT VOLTAGE ADJUST RANGE	CH1 : 11 V ~ 13.5 V	I/P : 24 VDC I/P : 18 VDC O/P : MIN LOAD Ta : 25°C	9 V~ 14 V/ 24 VDC 9 V~ 14 V/ 18 VDC	P
3	OUTPUT VOLTAGE TOLERANCE	V1 : -1% ~ +1% (Max)	I/P : 18 VDC / 36 VDC O/P : FULL/ MIN LOAD Ta : 25°C	V1 : -0.03 %~ +0.03 %	P
4	LINE REGULATION	V1 : -1% ~ +1% (Max)	I/P : 18 VDC ~ 36 VDC O/P : FULL LOAD Ta : 25°C	V1 : -0.02 %~ +0.02 %	P
5	LOAD REGULATION	V1 : -1% ~ +1% (Max)	I/P : 24 VDC O/P : FULL ~MIN LOAD Ta : 25°C	V1 : -0.03 %~ +0.03 % ~	P
6	SET UP TIME	24VDC : 2000 ms (Max)	I/P : 24 VDC O/P : FULL LOAD Ta : 25°C	24VDC : 1050 ms	P
7	RISE TIME	24VDC : 50 ms (Max)	I/P : 24 VDC O/P : FULL LOAD Ta : 25°C	24VDC : 16 ms	P
8	DYNAMIC LOAD	V1 : 1200 mVp-p	I/P : 24 VDC O/P : FULL /Min LOAD 90%DUTY/ 1KHZ Ta : 25°C	700 mVp-p	P

INPUT FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	INPUT VOLTAGE RANGE	18 VDC ~ 36 VDC	I/P : TESTING O/P : FULL LOAD Ta : 25°C	18 V ~ 36 V	P
			I/P : LOW-LINE= 18 V HIGH-LINE=36 V O/P : FULL/MIN LOAD ON : 30 Sec . OFF : 30 Sec 10MIN (AC POWER ON/OFF NO DAMAGE)	TEST : OK	
2	EFFICIENCY	77 % (TYP)	I/P : 24 VAC O/P : FULL LOAD Ta : 25°C	81 %	P
3	INPUT CURRENT	24V/ 2.5 A (TYP)	I/P : 24 VDC O/P : FULL LOAD Ta : 25°C	I = 1.52 A / 24 VDC	P

PROTECTION FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	OVER LOAD PROTECTION	105 % ~ 150 %	I/P : 24 VDC I/P : 18 VDC O/P : TESTING Ta : 25°C	121.6 % / 24VDC 120 % / 18VDC Hiccup Mode	P
2	OVER VOLTAGE PROTECTION	CH1 : 14 V ~ 16.5 V	I/P : 24 VDC I/P : 18 VDC O/P : MIN LOAD Ta : 25°C	15.16 V / 24 VDC 15.16 V / 18 VDC Hiccup Mode	P
3	SHORT PROTECTION	SHORT EVERY OUTPUT 1 HOUR NO DAMAGE	I/P : 36 VDC O/P : FULL LOAD Ta : 25°C	NO DAMAGE Hiccup Mode	P

COMPONENT STRESS TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	Power Transistor (D to S) or (C to E) Peak Voltage	Q1 Rated : 100 V 27 A	I/P : High-Line +3V = 39 V O/P : (1)Full Load Turn on (2) Output Short (3)Full load continue Ta : 25°C	(1) 67.2 V (2) 64 V (3) 67.2 V	P
2	Diode Peak Voltage	D100 Rated : 200 V 10 A	I/P : High-Line +3V = 39 V O/P : (1)Full Load Turn on (2)Output Short (3)Full load continue Ta : 25°C	(1) 121 V (2) 70 V (3) 121 V	P
3	Clamp Diode Peak Voltage	D6 Rated : 200 V 1 A	I/P : High-Line +3V = 39 V O/P : (1) Dynamic Load 90%Duty/1KHz (2)Full load continue Ta : 25°C	(1) 43.6 V (2) 54 V	P
4	Input Capacitor Voltage	C5 Rated : 100 u / 330 V / 105 °C	I/P : High-Line +3V = 39 V O/P : (1)Full Load Turn on /Off (2) Min load Turn on /Off (3)Full Load /Min load Change Ta : 25°C	(1) 38.7 V (2) 39.5 V (3) 38.5 V	P
5	Control IC Voltage Test	U1 Rated : 30 V	I/P : High-Line +3V = 39 V O/P : (1)Full Load Turn on /Off (2) Min load Turn on /Off (3)Full Load /Min load Change Ta : 25°C	(1) 16.4 V (2) 12.7 V (3) 16.4 V	P

■ SAFETY & E.M.C. TEST

SAFETY TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	WITHSTAND VOLTAGE	I/P-O/P : 1.5 KVAC/min I/P-FG : 1.5 KVAC/min O/P-FG : 0.5 KVAC/min	I/P-O/P : 1.8KVAC/min I/P-FG : 1.8 KVAC/min O/P-FG : 0.6 KVAC/min Ta : 25°C	I/P-O/P : 0.17 mA I/P-FG : 0.58 mA O/P-FG : 3.12 mA NO DAMAGE	P
2	ISOLATION RESISTANCE	I/P-O/P : 500VDC>100MΩ I/P-FG : 500VDC>100MΩ O/P-FG : 500VDC>100MΩ	I/P-O/P : 500 VDC I/P-FG : 500 VDC O/P-FG : 500 VDC Ta : 25°C/70%RH	I/P-O/P : >9.99 GΩ I/P-FG : >9.99 GΩ O/P-FG : 3.62 GΩ NO DAMAGE	P

E.M.C TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	RADIATION	EN55022 CLASS B	I/P : 12VDC O/P : FULL LOAD Ta : 25°C	ok	p
2	E.S.D	EN61000-4-2 LIGHT INDUSTRY AIR : 8KV / Contact : 4KV	I/P : 12VDC O/P : FULL LOAD Ta : 25°C	ok	p
3	E.F.T	EN61000-4-4 LIGHT INDUSTRY INPUT : 1KV	I/P : 12VDC O/P : FULL LOAD Ta : 25°C	ok	p
4	SURGE	IEC61000-4-5 LIGHT INDUSTRY L-N : 1KV L,N-PE : 2KV	I/P : 12VDC O/P : FULL LOAD Ta : 25°C	ok	p
5	Test by certified Lab & Test Report Prepare				

■ RELIABILITY TEST

ENVIRONMENT TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	TEMPERATURE RISE TEST	MODEL : PSD-30B-12 1. ROOM AMBIENT BURN-IN : 1 HRS I/P : 12VDC O/P : FULL LOAD Ta=36.7°C 2. HIGH AMBIENT BURN-IN : 1 HRS I/P : 12VDC O/P : FULL LOAD Ta=44.8°C			p
3	OVER LOAD BURN-IN TEST	NO DAMAGE 1 HOUR (MIN)	I/P : 12VDC O/P : 128% LOAD Ta : 25°C	TEST : ok	p
4	LOW TEMPERATURE TURN ON TEST	TURN ON AFTER 2 HOUR	I/P : 18VDCAC/100VAC O/P : 100 % LOAD Ta= -20°C	TEST : ok	p

5	HIGH HUMIDITY HIGH TEMPERATURE HIGH VOLTAGE TURN ON TEST	AFTER 12 HOURS IN CHAMBER ON CONTROL 50°C NO DAMAGE	I/P : 272 VAC O/P : FULL LOAD Ta=50°C HUMIDITY= 95 %R.H	TEST : ok	p
6	TEMPERATURE COEFFICIENT	±0.03%(0~50°C)	I/P : 12VDC O/P : FULL LOAD	±0.02%(0~50°C)	p
7	STORAGE TEMPERATURE TEST	1. Thermal shock Temperature : -20°C~ +85°C 2. Temperature change rate : 25°C / MIN 3. Dwell time low and high temperature : 30 MIN/EACH 4. Total test cycle : 5 CYCLE 5. Input/Output condition : STATIC		ok	p
8.	THERMAL SHOCK TEST	1. Thermal shock Temperature : -20°C~ +60°C 2. Temperature change rate : 25°C / MIN 3. Dwell time low and high temperature : 30 MIN/EACH 4. Total test cycle : 10 CYCLE 5. Input/Output condition : 12VDC/Full Load		ok	p
9	VIBRATION TEST	1 Carton & 1 Set (1) Waveform : Sine Wave (2) Frequency : 10~500Hz (3) Sweep Time : 12min/sweep cycle (4) Acceleration : 2G (5) Test Time : 60min in each axis (X.Y.Z) (6) Ta : 25°C		TEST : ok	p
10	CAPACITOR LIFE CYCLE	SUPPOSE C100 IS THE MOST CRITICAL COMPONENT (1) I/P : 12VDC O/P : FULL LOAD Ta=25°C LIFE TIME (2) I/P : 12VDC O/P : FULL LOAD Ta=50°C LIFE TIME		(2) 354852HRS (3) 62237HRS	p
11	MTBF	MIL-HDBK-217F NOTICES2 PARTS COUNT TOTAL FAILURE RATE : 902.4 HRS			p

DATE	SAMPLE	TEST RESULT	TESTER	APPROVAL
2009/9/8	RD SAMPLE	PASS	何马超、葛双根	王德昭

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